

**Search Notes**

Application/Control No.

10/531,934

Examiner

Michelle Estrada

Applicant(s)/Patent under  
Reexamination

VAN BEEK ET AL.

Art Unit

2823

**SEARCHED**

Class	Subclass	Date	Examiner
438	48	11/22/2005	ME
438	50	11/22/2005	ME
438	422	11/22/2005	ME

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR